Synthesis Of Chromium Thin Film & Its Thickness Measurement using Alpha Source



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Setup & Process(Alpha source

thickness monitor)

Caution

Alpha source

inside

Introduction

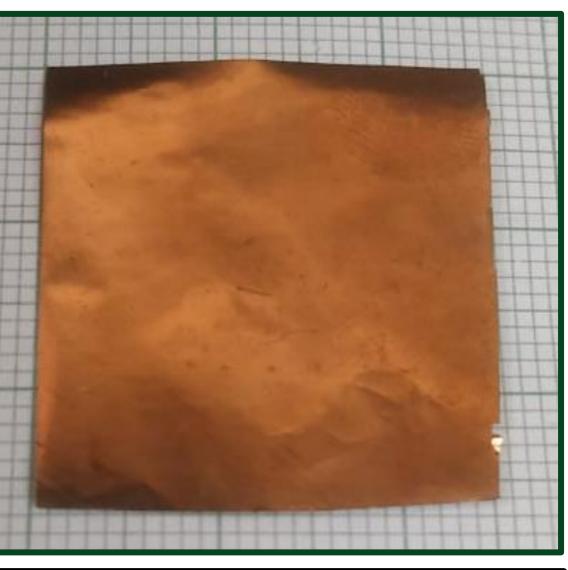
- Self-supporting thin films as targets are required in nuclear and various other research fields.
- Preparation of these films with uniformity and correct thickness is a very crucial part.
- To get the accurate thickness of prepared thin films is utmost important.
- Using an alpha source we can get a very accurate reading of the prepared thin film.

Setup (Thin Film Synthesis)

- Setup consists of a chamber, a rotary and a diffusion pump for vacuum.
- There are two copper electrodes through which flowing high current produces heat due to resistance.
- High heat evaporates material

Process

- For preparation of Chromium thin film we need copper film substrates.
- Copper thin film substrates were prepared using cold rolling setup.
- For preparation of chromium film, substrates were cleaned with nitric acid and then placed inside the chamber at height of 16mm from boat.
- Chromium granules were first crushed to fine powder with handheld ceramic crusher.
- 11 mg of chromium powder was used to achieve thickness of film in between 1-2 mg/cm².



Copper Thin Film Substrate



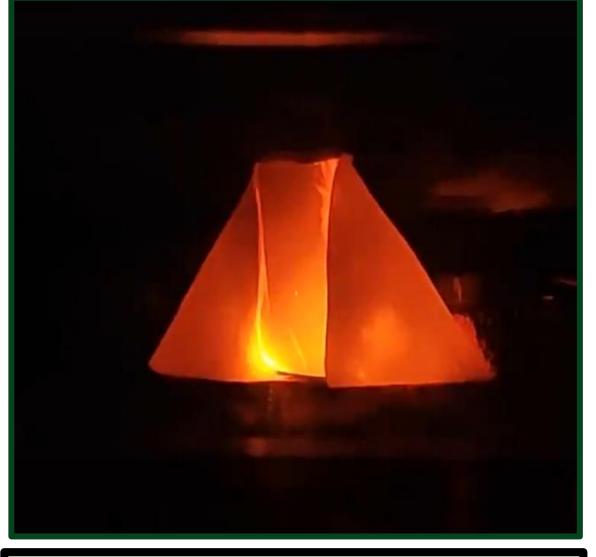
Substrate setup inside chamber



Chromium deposited on Copper film

hours to dissolve copper.

chromium thin film is ready.



Boat and substrate(16mm)

The prepared Chromium film on copper substrate

ounts 200

is dipped in 40% conc nitric acid solution for 6

Once copper is dissolved final self-supporting

- Film is mounted to the holder and placed in the chamber where it is exposed to alpha particles.
- These particles pass through the film losing energy and are then detected on to detector.
- Source of Alpha Americium(241) & Plutonium(238).

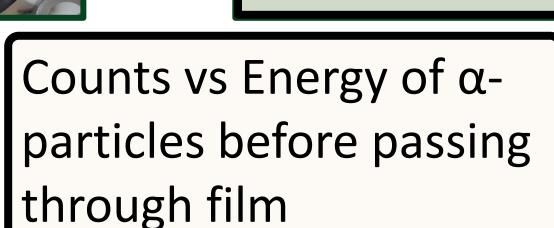


 $y=y0 + (A/(w*sqrt(pi/2)))*exp(-2*((x-xc)/w)^2$

5.15894 ± 3.70765E-4

 $y=y0 + (A/(w*sqrt(pi/2)))*exp(-2*((x-xc)/w)^{n}$

5.48876 ± 5.90233E-4



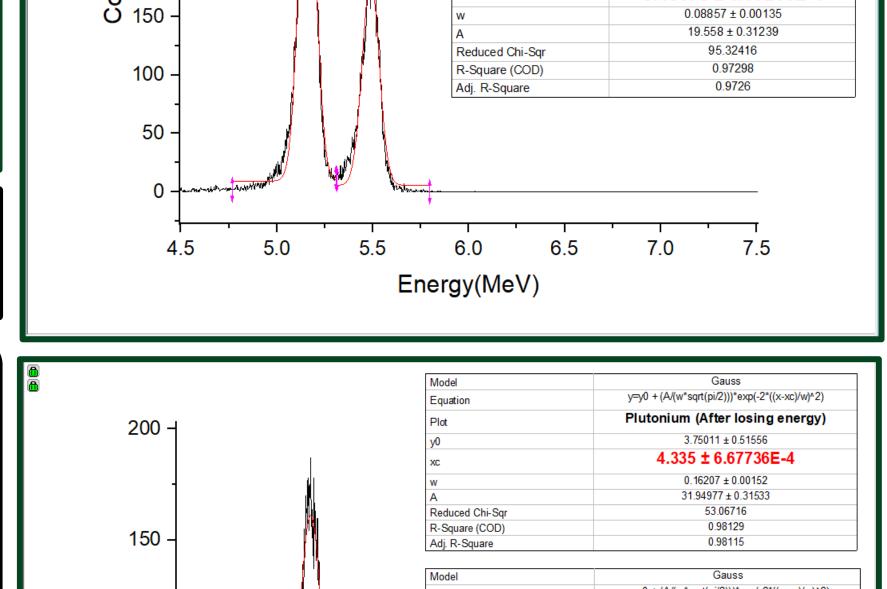
Source

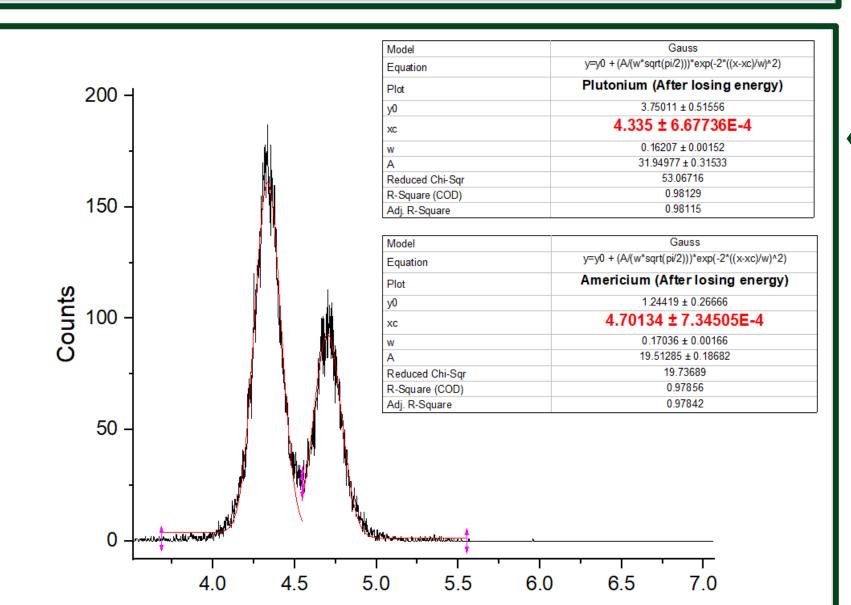
- Taller peak is for Plutonium α-particles with energy
 5.158 MeV
- Shorter peak is for Americium α-particles with Energy 5.48 MeV



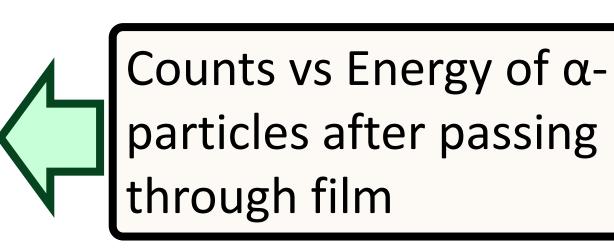
Self-supporting chromium film

- Thickness was calculated using weight/area formula
- Thickness found ≈1.5 mg/cm².





Energy (MeV)



- α-particles lose energy after passing through film using this loss in energy we calculate the thickness of the film.
- Prepared Film thickness- 1.7 mg/cm².



